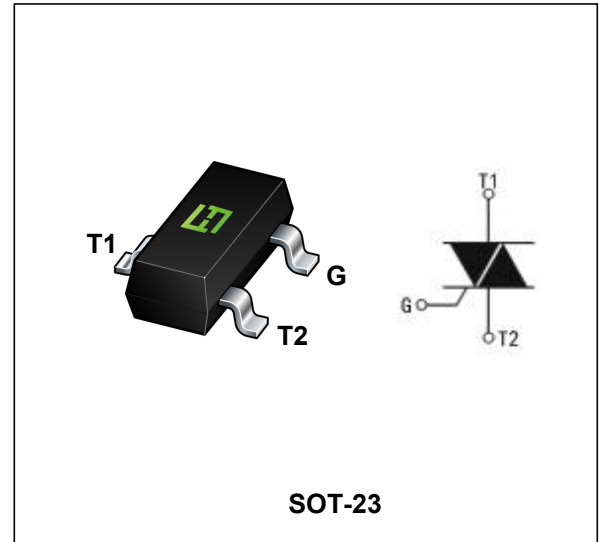


Features

- Direct interfacing to logic level ICs
- Direct interfacing to low power gate drivers and microcontrollers
- High blocking voltage capability
- Planar passivated for voltage ruggedness and reliability
- Triggering in all four quadrants
- Very sensitive gate

Applications

- General purpose low power phase control
- General purpose low power switching
- Solid-state relay



Marking: 97A6

Maximum Ratings

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DRM}	Repetitive peak off-state voltage		-	400	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; $T_{lead} \leq 50^{\circ}C$	-	0.8	A
I_{TSM}	Non repetitive surge peak on-state current	full sine wave; $T_{j(init)} = 25^{\circ}C$; $t_p = 20$ ms	-	8	A
		full sine wave; $T_{j(init)} = 25^{\circ}C$; $t_p = 16.7$ ms	-	8.8	A
I^2t	I^2t Value for fusing	$t_p = 10$ ms; SIN	-	0.32	A ² S
di_T/dt	Critical rate of rise of on-state current	$I_T=1$ A; $I_G=20$ mA; $dI_G/dt=0.2$ A/ μ s; T2+ G+	-	50	A/ μ S
		$I_T=1$ A; $I_G=20$ mA; $dI_G/dt=0.2$ A/ μ s; T2+ G-	-	50	A/ μ S
		$I_T=1$ A; $I_G=20$ mA; $dI_G/dt=0.2$ A/ μ s; T2- G-	-	50	A/ μ S
		$I_T=1$ A; $I_G=20$ mA; $dI_G/dt=0.2$ A/ μ s; T2- G+	-	10	A/ μ S
I_{GM}	Peak gate current	$t=20$ microsecs(max)	-	1	A
P_{GM}	Peak gate power	$t=20$ microsecs(max)	-	5	W

Symbol	Parameter	Conditions	Min	Max	Unit
$P_{G(AV)}$	Average gate power	over any 20ms period ; $T_{(lead)} \leq 80^{\circ}C$; $t = 2$ microseconds(max)	-	0.1	W
T_{stg}	Storage temperature		-40	150	$^{\circ}C$
T_j	Junction temperature		-	125	$^{\circ}C$

Static Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
I_{GT}	Gate trigger current	$V_D=12V$; $I_T=0.1A$; $T_2+ G+$; $T_j=25^{\circ}C$	-	1	5	mA
		$V_D=12V$; $I_T=0.1A$; $T_2+ G-$; $T_j=25^{\circ}C$	-	2	5	mA
		$V_D=12V$; $I_T=0.1A$; $T_2- G-$; $T_j=25^{\circ}C$	-	2	5	mA
		$V_D=12V$; $I_T=0.1A$; $T_2- G+$; $T_j=25^{\circ}C$	-	4	7	mA
I_L	Latching current	$V_D=12V$; $I_G=0.1A$; $T_2+ G+$; $T_j=25^{\circ}C$	-	1	10	mA
		$V_D=12V$; $I_G=0.1A$; $T_2+ G-$; $T_j=25^{\circ}C$	-	5	10	mA
		$V_D=12V$; $I_G=0.1A$; $T_2- G-$; $T_j=25^{\circ}C$	-	1	10	mA
		$V_D=12V$; $I_G=0.1A$; $T_2- G+$; $T_j=25^{\circ}C$	-	2	10	mA
I_H	Holding current	$V_D = 12V$; $T_j=25^{\circ}C$	-	1	10	mA
V_T	On-state voltage	$I_T=0.85A$; $T_j=25^{\circ}C$	-	1.4	1.9	V
V_{GT}	Gate trigger voltage	$V_D=12V$; $I_T=0.1A$; $T_j=25^{\circ}C$	-	0.9	1.5	V
		$V_D=400V$; $I_T=0.1A$; $T_j=110^{\circ}C$	0.1	0.7	-	V
I_D	Off-state current	$V_D=400V$; $T_j=110^{\circ}C$	-	3	100	μA

Dynamic characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
dV_D/dt	Rate of rise of off-state voltage	$V_{DM}=268V$; $T_j=110^{\circ}C$; ($V_{DM}=67\%$ of V_{DRM}); exponential waveform; gate open circuit;	30	45	-	V/ μs
dV_{com}/dt	Rate of change of commutating voltage	$V_D=400V$; $T_j=50^{\circ}C$; $dI_{com}/dt=0.3A/ms$; $I_T=0.84A$; gate open circuit	-	5	-	V/ μs
t_{gt}	Gate-controlled turn-on time	$I_{TM}=1A$; $V_D=400V$; $I_G=25mA$; $dI_G/dt=5A/\mu s$	-	2	-	μs

Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-lead)}$	thermal resistance from junction to lead	full cycle;	-	-	60	K/W
		half cycle	-	-	80	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	printed circuit board mounted: lead length=4mm	-	150	-	K/W

Fig. 1. RMS on-state current as a function of surge duration; maximum values

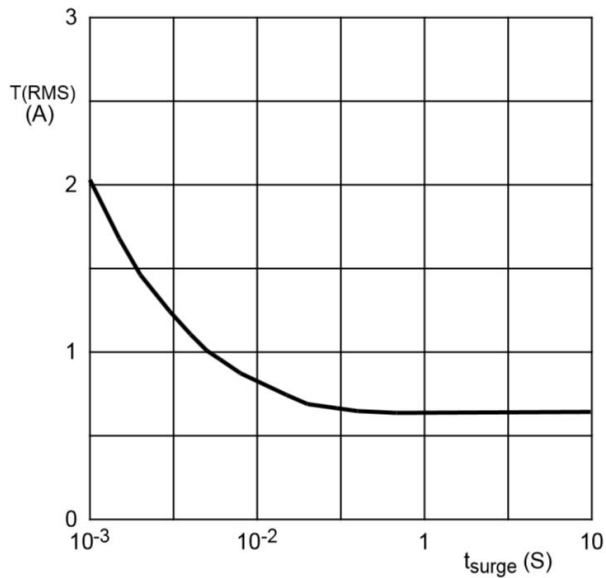


Fig. 2. RMS on-state current as a function of lead temperature; maximum values

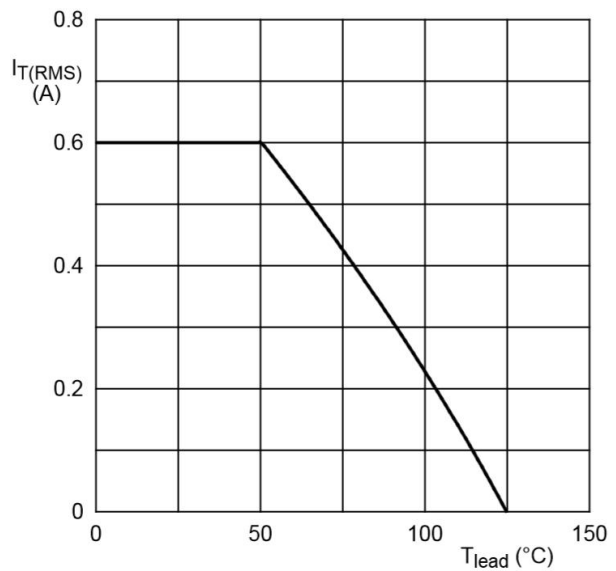
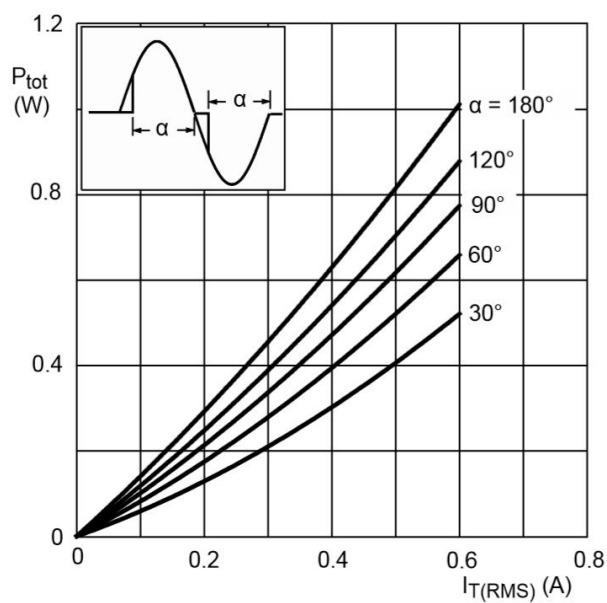


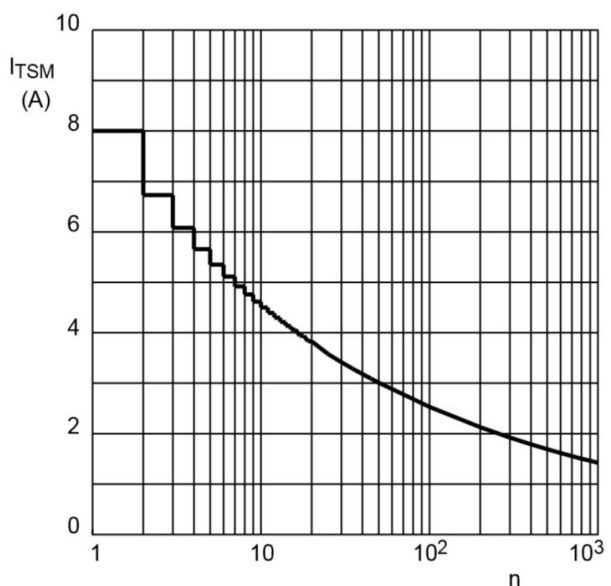
Fig. 3. Total power dissipation as a function of RMS on-state current; maximum values



α = conduction angle

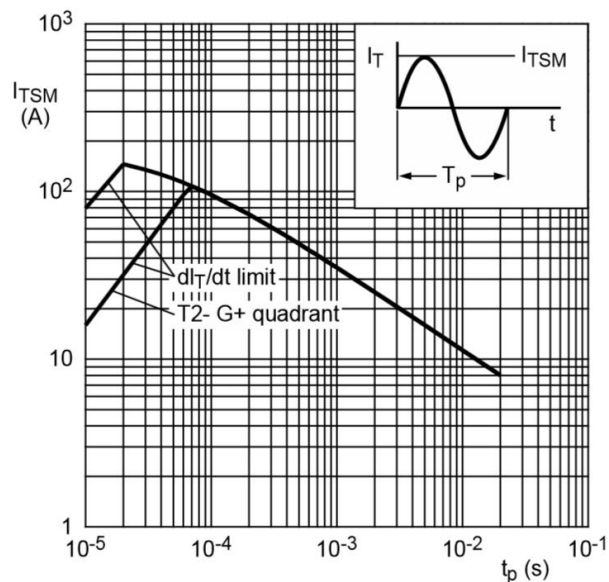
a = form factor = $I_{T(\text{RMS})} / I_{T(\text{AV})}$

Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



$f = 50 \text{ Hz}$

Fig. 5. Non-repetitive peak on-state current as a function of pulse width; maximum values



$t_p \leq 20$ ms

Fig. 6. Transient thermal impedance from junction to ambient as a function of pulse width

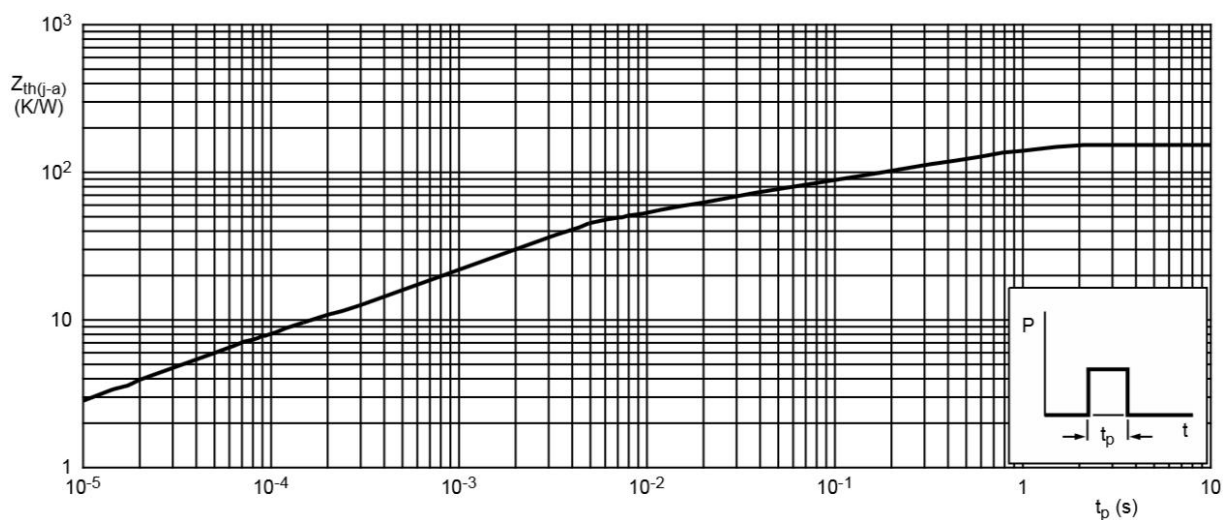
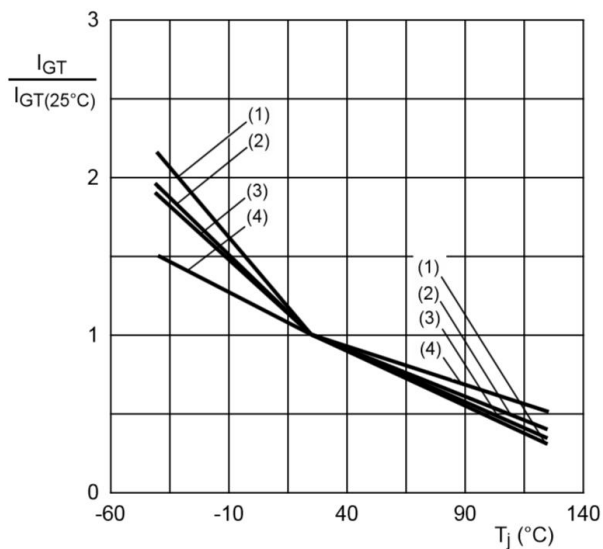


Fig. 7. Normalized gate trigger current as a function of junction temperature



- (1) T2- G+
- (2) T2- G-
- (3) T2+ G-
- (4) T2+ G+

Fig. 8. Normalized latching current as a function of junction temperature

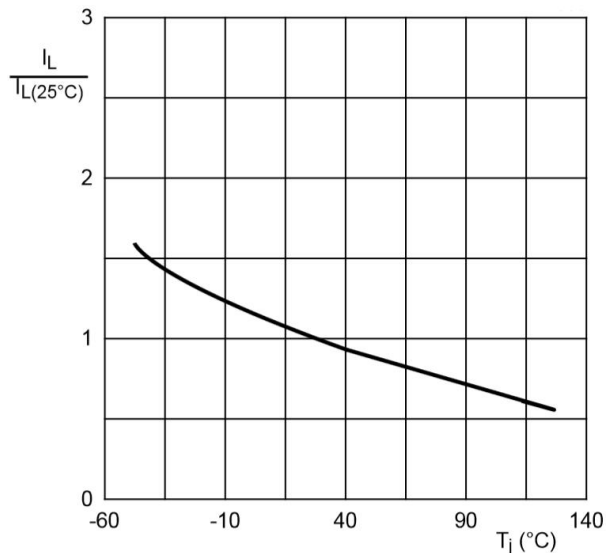


Fig. 9. Normalized holding current as a function of junction temperature

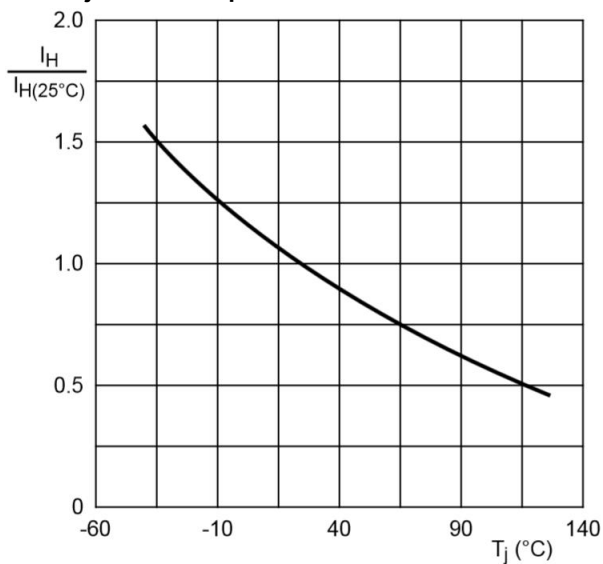
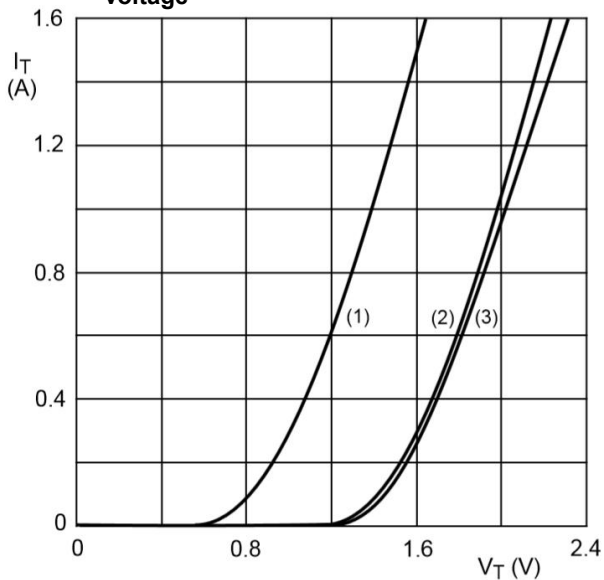


Fig. 10. On-state current as a function of on-state voltage



$V_O = 1.45 \text{ V}; R_S = 0.1875 \Omega$

- (1) $T_j = 125^\circ\text{C}$; typical values
- (2) $T_j = 125^\circ\text{C}$; maximum values
- (3) $T_j = 25^\circ\text{C}$; maximum values

Fig. 11. Normalized gate trigger voltage as a function of junction temperature

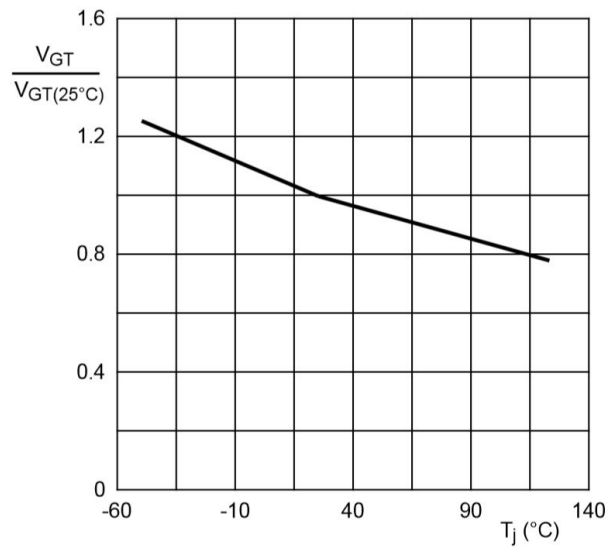
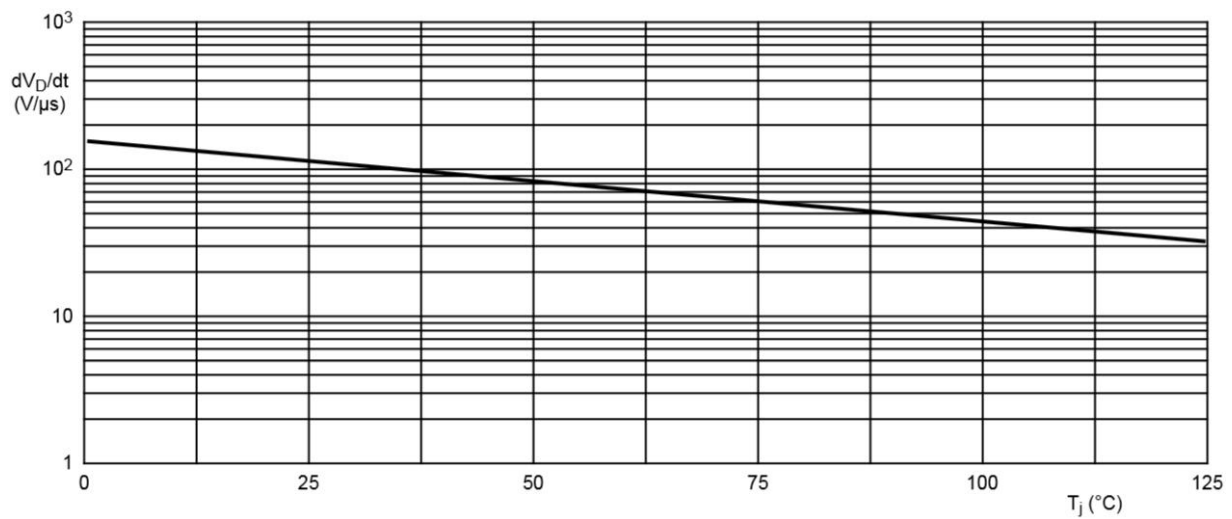
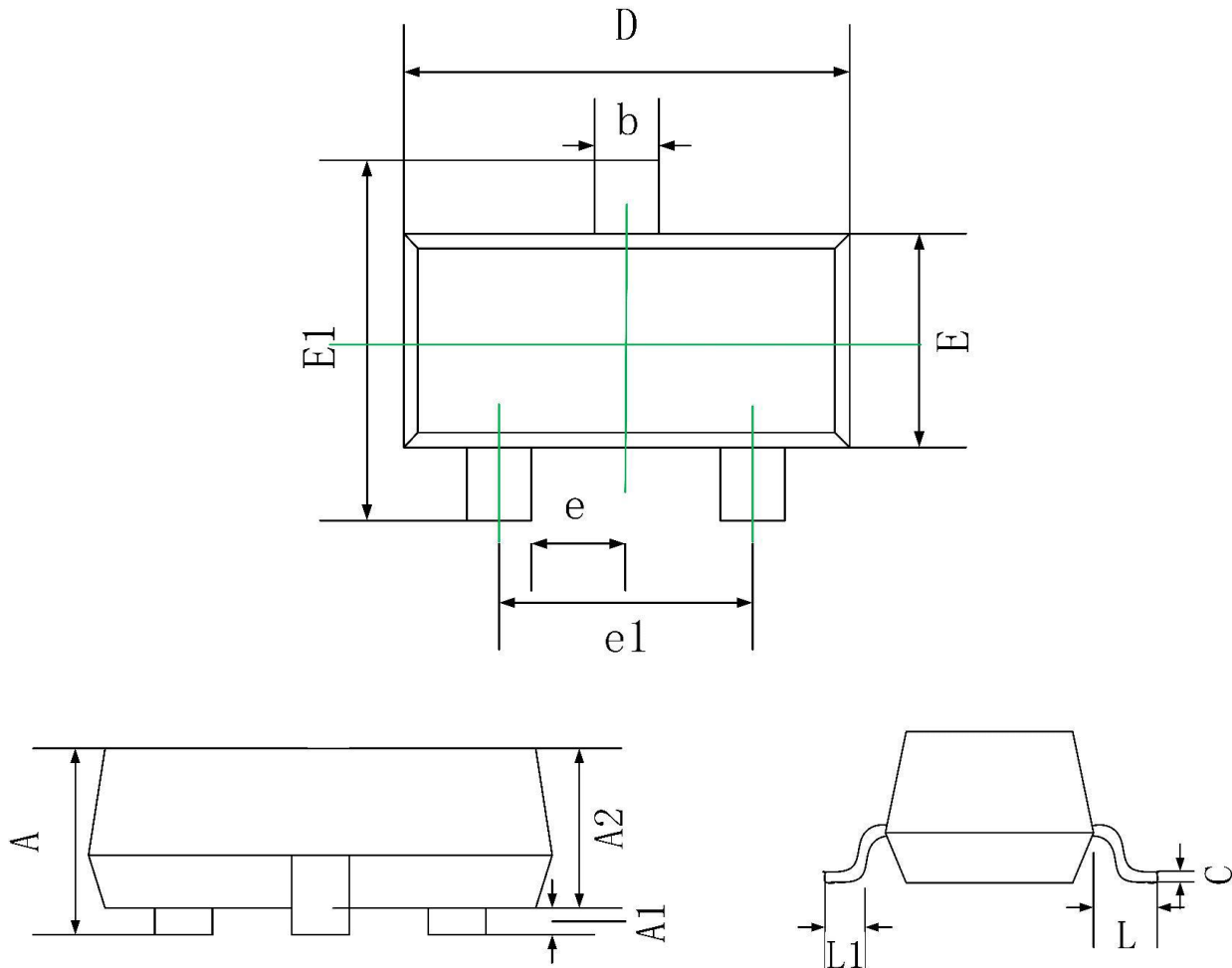


Fig. 12. Critical rate of rise of off-state voltage as a function of junction temperature; typical values



SOT-23 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP.		0.037 TYP.	
e1	1.800	2.000	0.071	0.079
L	0.550 REF.		0.022 REF.	
L1	0.300	0.500	0.012	0.020